## T AVAIL ABILL DODY

N	otice	of	Refe	rences	Cited

Examiner Art Unit	Application/Control No. 10/089,959	Applicant(s)/Patent Under Reexamination WALKE ET AL		
	Examiner CongVan Tran		Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,501,741	12-2002	Mikkonen et al.	370/310
	В	US-6,587,680	07-2003	Ala-Laurila et al.	455/411
	С	US-6,052,594	04-2000	Chuang et al.	455/450
	D	US-6,580,700	06-2003	Pinard et al.	370/332
	Ε	US-6,377,782	04-2002	Bishop et al.	455/3.01
	F	US-6,792,286	09-2004	Bharath et al.	455/554.2
	G	US-6,728,244	04-2004	Takabatake, Yoshiaki	370/392
	Н	US-			0707002
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	•				
	0					
	Р					
	α	. :				
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.